TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

2SK2991

DC-DC Converter Relay Drive and Motor Drive Applications

• Low drain-source ON resistance : RDS (ON) = 1.35 Ω (typ.) • High forward transfer admittance : $|Y_{fs}| = 4.0 \text{ S (typ.)}$

• Low leakage current $: I_{DSS} = 100 \,\mu\text{A} \,(\text{max}) \,(V_{DS} = 500 \,\text{V})$

• Enhancement-mode : $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	500	V	
Drain-gate voltage (R _{GS} = 20 kΩ)		V_{DGR}	500	V	
Gate-source voltage		V_{GSS}	±30	V	
Drain current	DC (Note 1)	I _D	5	Α	
	Pulse (Note 1)	I _{DP}	20	Α	
Drain power dissipation (Tc = 25°C)		P_{D}	50	W	
Single pulse avalanche energy (Note 2)		E _{AS}	180	mJ	
Avalanche current		I _{AR}	5	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	4	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	2.5	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

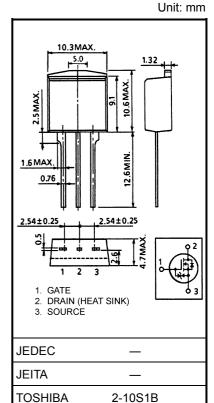
Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: V_{DD} = 90 V, T_{ch} = 25°C (initial), L = 12.2 mH, R_G = 25 Ω , I_{AR} = 5 A

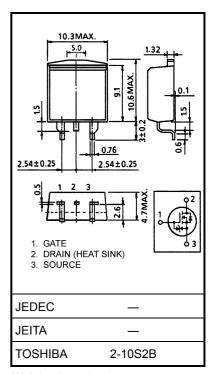
Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device.

Please handle with caution.



Weight: 1.5 g (typ.)



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Electrical Characteristics (Ta = 25°C)

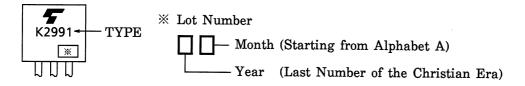
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±25 V, V _{DS} = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I _G = ±10 μA, V _{DS} = 0 V	±30	_	_	V
Drain cut-off cui	rrent	I _{DSS}	V _{DS} = 500 V, V _{GS} = 0 V	_	_	100	μA
Drain-source br	eakdown voltage	V _{(BR) DSS}	I _D = 10 mA, V _{GS} = 0 V	500	_	_	٧
Gate threshold v	voltage	V_{th}	V _{DS} = 10 V, I _D = 1 mA	2.0	_	4.0	٧
Drain-source Ol	N resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 2.5 A	_	1.35	1.50	Ω
Forward transfer	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 2.5 A	2.5	4.0	_	S
Input capacitano	e	C _{iss}		_	780	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	60	_	pF
Output capacitance		Coss		_	200	_	
Switching time	Rise time	t _r	$V_{GS} = 0V$ $I_{D} = 2.5A$ V_{OUT} $R_{L} = 90\Omega$	_	12	_	- ns
	Turn-on time	t _{on}		_	25	_	
	Fall time	t _f		1	15		
	Turn-off time	t _{off}	$\begin{array}{c} V_{DD} = 225V \\ Duty \leq 1\%, \ t_{W} = 10\mu s \end{array}$		60	_	
Total gate charge (gate-source plus gate-drain)		Qg			17		
Gate-source charge		Q _{gs}	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		11	_	nC
Gate-drain ("miller") Charge		Q_{gd}			6	_	

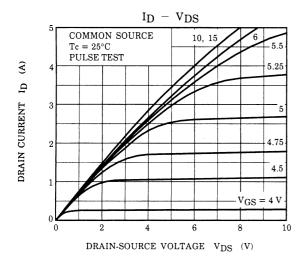
Source-Drain Ratings and Characteristics (Ta = 25°C)

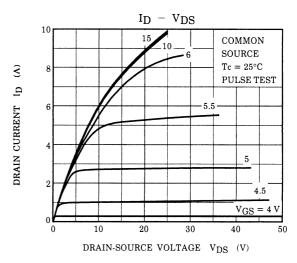
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	-	_	_	5	Α
Pulse drain reverse current (Note 1)	I _{DRP}	-	_	_	20	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 5 A, V _{GS} = 0 V	_	_	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 5 A, V _{GS} = 0 V, dI _{DR} / dt = 100 A / μs	_	1400	1	ns
Reverse recovery charge	Q _{rr}	1DR - 3 A, VGS - 0 V, αIDR / αι - 100 A / μs	_	9	-	μC

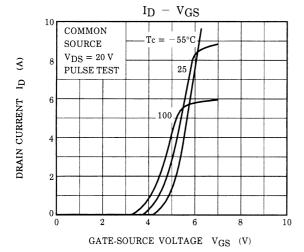
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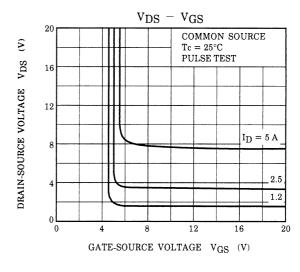
Marking

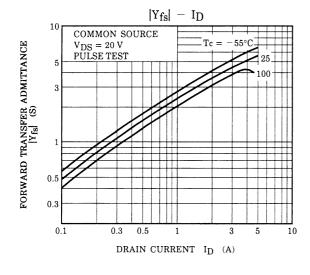


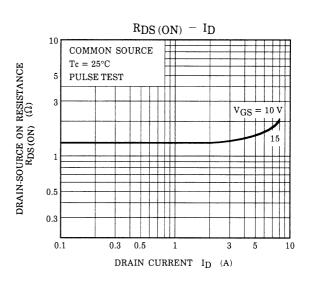




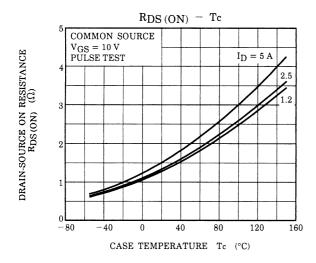


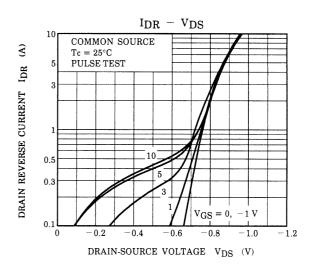


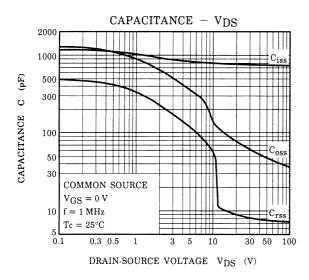


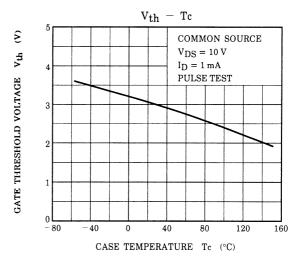


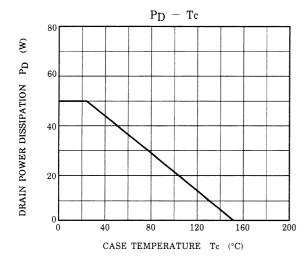
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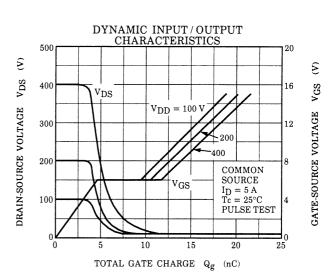


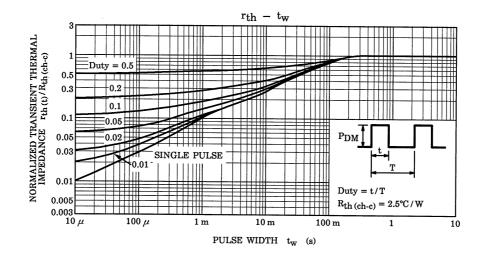


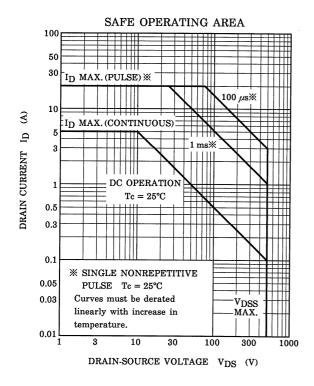


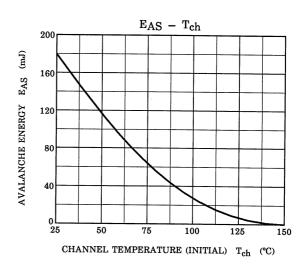


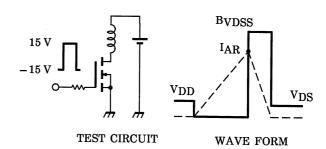












$$R_G = 25 \Omega$$

 $V_{DD} = 90 \text{ V}, L = 12.2 \text{ mH}$ $E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{B_{VDSS}}{B_{VDSS} - V_{DD}}\right)$

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